

Search Notes**Application/Control No.**

10/784,820

Examiner

Tan V. Mai

**Applicant(s)/Patent under
Reexamination**

YIP ET AL.

Art Unit

2193

SEARCHED

Class	Subclass	Date	Examiner
updated	search	3/5/2008	MAI

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
708	319	3/5/2008	MAI
PGPUB text search (see interference search printout)		3/5/2008	MAI

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated search (see printout)	3/5/2008	MAI